Call for papers - Computación y Sistemas Special Issue on Plagiarism Detection and Authorship Analysis

The Web is not only the greatest repository of digital information ever invented but also the largest communication platform. Its current development has allowed the exchange of information among people from different places, ages, cultures and conditions. However, it also has facilitated the dissemination of anonymous texts as well as the inappropriate copy and use of content from others. This situation has raised great research interest in plagiarism detection technologies and authorship analysis approaches, which focus on answering important questions such as, given a document, is it an original? Who wrote it? What are its author's traits?

In particular this special issue aims at compiling research progress in all aspects of plagiarism detection and authorship analysis as well as on their challenges and applications to business intelligence, personalized search, computer forensics and security.

Topics and guidelines

The topics of the special issue include, but are not limited to:

- Plagiarism detection
- Authorship Attribution
- · Authorship Verification
- · Author Profiling
- Personality Prediction from text
- Negative Social Behavior Detection (sexual harassment, bullying, online discrimination, etc.)

Submissions are invited for papers presenting high quality, previously unpublished research. Selection criteria include originality of ideas, correctness, clarity and significance of results and quality of presentation. Papers must be formatted according to the author guidelines for Computación y Sistemas papers, available at: http://cys.cic.ipn.mx/ojs/index.php/CyS.

All submissions should be submitted via email to the guest editors.

Important dates

Deadline for paper submission:

 First round of reviews:
 Re-submission of papers with major-revision:
 Final decision:

 Expected publication of the special issue:
 November 14, 2016

 December 16, 2016

 February 3, 2017
 February 10, 2017
 March/April 2017

Guest editors

- Manuel Montes y Gómez, INAOE, Mexico mmontesg@inaoep.mx
- Luis Villaseñor Pineda, INAOE, Mexico villasen@inaoep.mx

